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LIST OF REFERENCES CITED BY
APPLICANT

(REVISED FORM PTO-1449)

DATED: July 24, 2002

Applicant: Masanori MOCHIZUKI

U.S. Filing Date:
November 2, 2001Art Unit:
3724

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.							DATE	NAME	Cl.	Sub- Cl.	Fil. Date
	AB	3	3	4	7	6	0	3	10/1967	Ignatjev	-	-	-
	AC	3	6	2	2	2	1	1	11/1971	Mitton	-	-	-
	AD	3	8	5	9	0	0	3	01/1975	Schulz et al.	-	-	-
	AE	4	3	4	6	9	4	5	08/1982	Tsuboi	-	-	-
	AF	5	1	6	1	9	2	6	11/1992	Schulz	-	-	-

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.							DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
													Yes	No
	AG	0	9	2	4	0	2	5	06/1999	Europe	-	-	x	
	AH	11	1	8	2	5	4	5	07/1999	Japan	-	-	=AG	

OTHER DOCUMENTS

EXAMINER

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Sheet <u>1</u> of <u>1</u>				Atty. Docket No. 4272		Serial No.: 10/053,221			
LIST OF REFERENCES CITED BY APPLICANT (REVISED FORM PTO-1449) DATED <u>March 8, 2002</u>				Applicant: Masanori MOCHIZUKI					
				U.S. Filing Date: November 2, 2001		Art Unit: 3724			
U. S. PATENT DOCUMENTS									
EXAMINER INITIALS		DOCUMENT NO.		DATE	NAME	Cl.	Sub- Cl.		
FOREIGN PATENT DOCUMENTS									
		DOCUMENT NO.		DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
								Yes	No
		AA 3 - 8 1 0 3 5		04/1991	Japan	-	-	x	
OTHER DOCUMENTS									
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